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Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/002,919	HYON, SEUNG-TAEK	
Examiner	Art Unit	
Khai M. Nguyen	2617	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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East (see attached)	12/27/2006	KN